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IN RE APPLICATION OF:

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GROUP: 2811

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EXAMINER: Shouxiang Hu

FOR: BOLOMETRIC DETECTOR WITH AN ANTENNA

SUBMISSION OF CERTIFIED ENGLISH TRANSLATION OF PRIORITY DOCUMENT

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Sir:

Applicant submits herewith a certified English translation of priority document
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Respectfully Submitted,

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IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF : AGNESE Patrick

SERIAL NO. : 09/869 590

FILED : December 28, 1999

FOR : BOLOMETRIC DETECTOR WITH AN ANTENNA

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DETECTEUR BOLOMETRIQUE A ANTENNE

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Code of Intellectual Property Rights – Book VI

APPLICATION FOR ISSUE OF CERTIFICATEFiling confirmation by fax ☐

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SUBMISSION OF DOCUMENTS: DATE : 30 DEC 1998 NATIONAL REGISTRATION NUMBER: 98 16648 FILING DEPARTMENT: 75 INPI PARIS DATE OF FILING: 30 DEC 1998					
1. NAME AND ADDRESS OF APPLICANT OR AGENT TO WHOM CORRESPONDENCE IS TO BE SENT BREVATOME 25, rue de Ponthieu 75008 PARIS 422-5/S002 permanent power ref refs of correspondent telephone 07068 B 13181.3 PR 01 53 83 94 00 Initial application for patent DD 1851 ▼ <input type="checkbox"/> Patent application <input type="checkbox"/> Certificate of utility no. date					
2. TYPE OF APPLICATION <input checked="" type="checkbox"/> Patent application <input type="checkbox"/> Divisional application <input type="checkbox"/> Certificate of utility <input type="checkbox"/> Conversion of a European patent application RESEARCH REPORT <input type="checkbox"/> differed <input checked="" type="checkbox"/> immediate The applicant, an individual, requires payment of fees in installments <input type="checkbox"/> yes <input type="checkbox"/> no TITLE OF INVENTION (no more than 200 characters or spaces) BOLOMETRIC DETECTOR WITH AN ANTENNA					
3 APPLICANT(s) SIREN No. APE-NAF code Name and first names (underline surname) or company name Legal form COMMISSARIAT A L'ENERGIE ATOMIQUE Public undertaking with a scientific, technical and industrial nature Nationality (ies) French Full address(es) Country 31- 33 rue de la Fédération 75015 PARIS France If more space needed, continue on a separate sheet					
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B 13181.3 PR**PATENT CERTIFICATE OF UTILITY****DESIGNATION OF THE INVENTOR**

(if the applicant is not the inventor or the sole inventor)

NATIONAL REGISTRATION NUMBER

9816648**TITLE OF THE INVENTION****BOLOMETRIC DETECTOR WITH AN ANTENNA****THE UNDERSIGNED****M. DES TERMES****c/o BREVATOME****25 rue de Ponthieu****75008 PARIS****FRANCE****422-5/S002****DESIGNATE AS INVENTOR(S)** (state surname, first names, address and underline surname):**AGNESE Patrick****123, chemin Jules Renard****38340 VOREPPE****FRANCE****NB.** By way of exception, the name of the inventor may be followed by that of the company to which he is attached when the latter differs from the applicant or proprietary company**Date and signature(s) of the applicant(s) or agent****PARIS 30 DEC 1998****M. DES TERMES**

DOCUMENT COMPRISING MODIFICATIONS

PAGES OF DESCRIPTION OR CLAIMS OR DRAWINGS			CM*	DATE OF CORRESPONDENCE	DATE STAMP OF CORRECTOR
Modified	Deleted	Added			
Page 15 to 18			x	22-12-99	14 NOV 2000 ABU

Any change made to the wording of the original claims, unless arising out of the provisions of article R612-36 of the Intellectual Property Code, is indicated by the initials CM (claims modified)

BOLOMETRIC DETECTOR WITH AN ANTENNATechnical field and prior art

The invention relates to a bolometric detector with an antenna as well as to a method for manufacturing such a detector.

5 The invention is more specifically applied to the passive detection of electromagnetic waves with millimetric wavelengths.

The detection is said to be passive when the observed scene emits the signal to be detected, on its own, either directly by its own emission of a gray body
10 which it forms, or indirectly, by reflection on another gray body.

Passive detection of millimetric waves is presently based on two different principles.

According to a first principle, the
15 electromagnetic wave is detected by an antenna so as to generate an electric signal, the processing of which is carried out by an electronic circuit operating at the wave's frequency. According to a second principle, the electromagnetic wave is detected by an antenna so as to
20 generate a heat flux which is measured.

A disadvantage of the detectors operating according to the first principle is that they are limited in frequency.

Indeed, the technologies used for producing such
25 circuits, such as technologies based on gallium arsenide (AsGa) or indium phosphide (InP), are presently inaccessible at frequencies higher than 100 GHz, for example.

Moreover, in the case when the detectors have to
30 be brought together as a matrix of $n \times m$ detectors,

such circuits have high power dissipation, of the order of 1 Watt for a 32 x 32 matrix, for example. This is also a disadvantage.

5 Detectors operating according to the second principle form the class of bolometric detectors.

Bolometric detection is such that the power of the electromagnetic wave which is collected by the antenna is converted in a resistive load into heating power which is measured. Measurement of heating power is
10 performed by means of a thermal conductance which converts the heat flux into a rise in temperature relatively to a reference temperature. The thus determined rise in temperature is converted into an electric signal by a component, a so-called
15 "thermometric component".

A bolometric detector according to the known art is described in the article entitled "Antenna-coupled bolometer with a micromachined - beam thermal link" and published in the journal "Appl. Phys. Lett. 71 (16)" as
20 of October 20th 1997.

Such a bolometric detector comprises:

- a receiving antenna for collecting electromagnetic waves,
- a resistive load for converting the collected
25 electromagnetic power into heating power,
- a transmission line or guide for transmitting the electromagnetic waves received by the antenna to the resistive load,
- means for measuring the heating power.

30 The presence of the transmission line or guide between the receiving antenna and the resistive load has several disadvantages. A first disadvantage is that it participates not insignificantly to the bulkiness of

the bolometric detector. Another disadvantage is the difficulty in producing such a line or guide for high frequency circuits, such as for frequencies beyond 50 GHz.

5 The invention does not have such disadvantages.

 The invention relates to a bolometric detector comprising a receiving antenna for collecting electromagnetic waves, the receiving antenna having a load resistor, a resistive load for converting the
10 power of the received electromagnetic waves into heating power and means for measuring the heating power. The resistive charge is formed by the load resistor of the receiving antenna.

 The invention also relates to a method for
15 manufacturing a bolometric detector comprising a receiving antenna and a thermometric component. The manufacturing method consisting of the following steps:

 - a step for producing a structure formed by the stacking of a silicon substrate, an oxide layer and a
20 silicon layer,

 - a step for producing a doped area in the silicon layer in order to form the thermometric component as a diode and to cover the silicon layer with a silicon oxide layer,

25 - a step for producing the electric contacts of the diode,

 - a step for producing, by depositing a metal on the silicon oxide layer, the metal components forming the receiving antenna,

30 - a step consisting of dry etching the oxide and silicon layers in order to define a recessed area which localizes the diode,

 - a step consisting of depositing a passivation

layer and of etching this layer in order to leave free access to the electric contacts of the diode and areas for recovering electric contact with the antenna metal components,

5 - a step consisting of depositing a conducting layer on the electric contacts of the diode, on the areas for recovering electric contact with the antenna metal components and on the recessed area which localizes the diode,

10 - a step for removing the oxide located under the diode and under the recessed area that localizes the diode in order to create a cavity.

According to the preferred embodiment of the invention, a microbolometer silicon is associated with
15 a plane quadrupolar antenna arranged on a dielectric cavity formed by the silicon support itself and resonant at the frequencies of use. Such a configuration is particularly well suited for producing a complex focal plane with a $n \times m$ pixel matrix
20 structure enabling a low dissipation readout circuit to be integrated therein. It is understood that low dissipation means dissipation less than 100 mW for a 32×32 matrix, for example.

25 Brief description of the figures.

Other features and advantages of the invention will become apparent upon reading about a preferred embodiment of the invention with reference to the appended figures, wherein:

30 - Figure 1 represents a top view of a bolometric detector according to the invention,

 - Figure 2 represents a simplified sectional view of the bolometric detector according to Figure 1,

- Figure 3 represents a top view of the combination of four bolometric detectors according to a first embodiment of the invention,

5 - Figure 4 represents a top view of the combination of four bolometric detectors according to a second embodiment of the invention,

- Figure 5 represents a detailed view of a bolometric detector enhancement in the case of a combination of bolometric detectors according to the
10 second embodiment of the invention,

- Figures 6A-6H represent a method for manufacturing a bolometric detector according to the invention,

- Figure 7 represents an enhancement of the method
15 for manufacturing a bolometric detector according to Figures 6A and 6H.

In all the figures, the same references designate the same components.

20 Detailed description of the embodiments of the invention

Figure 1 represents a top view of a bolometric detector according to the invention.

Four plane metal components 2a, 2b, 2c, 2d lie on
25 a silicon layer 1. These four components are preferably arranged in the shape of a cross around a central recessed portion 7. Metal components 2a and 2c are aligned along an axis AA' and metal components 2b and 2d are aligned along an axis perpendicular to the AA'
30 axis.

In the central recessed portion 7, a conducting structure in the shape of a cross with four arms 3a, 3b, 3c, 3d enables the four metal components 2a, 2b,

2c, 2d to be connected with each other. Arms 3a and 3c are aligned along the AA' axis and arms 3b and 3d along the axis perpendicular to the AA' axis.

The four metal arms 3a, 3b, 3c, 3d cover a diode 4, there where they intersect. Diode 4 is produced as described later (cf. description, Figure 6).

The four plane metal components 2a, 2b, 2c, 2d form the antenna for receiving the signal. According to the invention, the metal components 2a, 2b, 2c, 2d also form the resistive load for converting the power of electromagnetic waves into heating power.

The thus dissipated heating power in the antenna metal components leads to heating of the arms 3a, 3b, 3c, 3d. Heating of arms 3a, 3b, 3c, 3d leads to heating of the diode 4. As a result, the diode 4 forms the thermometric component of the bolometric detector.

In the absence of any detection of electromagnetic waves, a reference current I_{ref} flows through the diode. When an electromagnetic wave is detected, diode 4 heats up and the current flowing through it differs from the I_{ref} current. Metallizations 5 and 6 provide connections from both terminals of diode 4 to a circuit (not shown in the figure) for processing the variations of the current flowing through the diode.

Diode 4 is implemented in a silicon wafer as shown in Figure 6A. A detector with very low specific heat capacity for room temperature operation, high thermal insulation is obtained through the resistive metal of components 3a, 3b, 3c, 3d and a high performance as regards low frequency noise is obtained because of the use of a thermometric diode on monocrystalline silicon.

As seen from above, the bolometric detector illustrated in Figure 1, forms a square of side ℓ .

According to the preferred embodiment of the invention, side ℓ is equal to $\lambda/2$, with λ the wavelength of a wave for which detection is desired.

In the case of signals to be detected within a frequency band, side ℓ , preferably, is equal to $\lambda/2$, wherein λ is set to the wavelength of the wave with a frequency equal to the central frequency of the band.

Figure 2 represents a simplified sectional view of the bolometric detector according to Figure 1. The section is taken along the AA' axis of Figure 1.

The structure of Figure 2 consists of a silicon substrate 8 on which an oxide layer, a silicon layer 1 and the metal components 2a, 2b forming an antenna are stacked successively.

The oxide 9 and silicon 1 layers are recessed in their central portion 7 in order to enable arms 3a and 3b as well as diode 4 to hang over the recess thus provided.

Figure 3 represents a top view of the combination of four bolometric detectors according to a first embodiment of the invention.

The four detectors are placed side by side in order to form, as seen from above, a square of side L.

According to the preferred embodiment of the invention, the length of side L is the wavelength λ of a wave for which detection is desired. In the case of signals to be detected within a frequency band, side L is preferably equal to the wavelength of the wave with a frequency equal to the central frequency of the frequency band. According to this embodiment of the invention, a horn does not then need to be associated with each bolometric detector. This embodiment is

particularly advantageous as an antenna horn is a relatively bulky 3-dimensional structure and cannot be made entirely by micro-machining of silicon.

5 However the invention also relates to the case when each detector itself forms a square for which side ℓ has a length equal to the wavelength λ . As a result, the combination of four detectors such as that of Figure 3 forms a structure for which side L is substantially equal to 2λ .

10 According to the preferred embodiment of the invention, the four thermometric diodes are mounted in parallel.

As described earlier (cf. Figure 1), each diode 4 is provided with a first terminal and a second terminal. 15 The conducting connections between the terminals of the different diodes are shown as broken lines in Figure 3.

A first set of connections converges towards the center of the detector and connects the first terminals 20 of the different diodes. A contact recovery R enables an electric contact to be established between the different connections of this first set and a connection line L_B of bus B .

A second set of connections $\ell_1, \ell_2, \ell_3, \ell_4$ provides 25 connection to a same electric reference such as for example the substrate, the second terminals of each diode.

Figure 4 represents a combination of four bolometric detectors according to a second embodiment 30 of the invention.

According to this second embodiment of the invention, the collected waves are of the TE and TM

type. As is known to the one skilled in the art, the acronym TE comes from the expression "Transverse Electric" and the acronym TM from the expression "Transverse Magnetic".

5 According to this embodiment, the conducting structure located in the central portion 7 of each bolometric detector and which partly covers each diode 4, only comprises two arms providing connections between two of the four metal components of the antenna
10 located facing each other. With reference to the notations of Figure 1, when the conducting structure of a first bolometric detector comprises two metal arms 3b, 3d connected to the antenna metal components 2b and 2d, then the metal arms 3a, 3c of the conducting
15 structures of both bolometric detectors which have a common face with the first bolometric detector are connected to the antenna metal components 2a, 2c.

 In the same way as in the case of Figure 3, the four bolometric detectors are placed side by side in
20 order to form, as seen from above, a square of side L.

 Both bolometric detectors located along a first diagonal of the square enable waves of a first type, for example of the TM type, to be collected, and the two bolometric detectors located along the diagonal
25 perpendicular to the first diagonal enable waves of a second type for example of the TE type, to be collected.

 A set of conducting connections (lines with broken segments and lines with continuous segments la , lb , lc ,
30 ld) enables the two diodes associated with two detectors which collect waves of the TM type, to be mounted in parallel on the one hand and enables the two diodes associated with two detectors which collect the

waves of the TE type to be mounted in parallel on the other hand.

A connection bus B_{TE} provides recovery R_1 of electrical contacts which correspond to the two diodes mounted in parallel associated with two detectors which collect the waves of the TE type. Similarly, a connection bus B_{TM} provides recovery R_2 of electrical contacts which correspond to two diodes mounted in parallel, associated with two detectors which collect the waves of the TM type.

Advantageously, the invention according to this second embodiment, because of TE and TM double polarization imaging, enables information rich in teachings to be collected on the nature of observable polarizing materials.

Figure 5 represents a detailed view of an enhancement of a bolometric detector in the case of a combination of bolometric detectors according to the second embodiment of the invention.

Figure 5 represents a recessed central portion of a bolometric detector. The central portion comprises two diodes 4 and 11. Diode 4 is partly covered with two conducting arms 3b, 3d, connected to the antenna metal components 2b, 2d. Diode 11 partly covered with two conducting arms 12b, 12d is located parallel to diode 4. Both conducting arms 12b and 12d are electrically insulated and connected to the thermal reference formed by the silicon substrate 8.

Diodes 4 and 11 are biased under the same conditions and may operate either under voltage or current.

Such a configuration enables all or part of the parasitic signals received by the bolometric detector

to be removed by differential readout of the signals derived from the diodes. In particular, signals located in the thermal infrared band may be removed advantageously. Similarly, all or part of the
5 fluctuations or parasitic drifts of the reference temperature of the bolometric detector may be removed.

Figures 6A-6H represent a method for manufacturing a bolometric detector according to a first embodiment of the invention.

10 Figure 6A represents the realization of a structure formed by stacking a silicon substrate 8, an oxide layer 9, for example of the SIMOX type, and a silicon layer 1, for example grown by epitaxy or deposited by transfer. The silicon layer 1 is for
15 example a layer of a few tenths of microns thick.

Figure 6B represents the realization of a doped area Z1 in the silicon layer 1 and the covering of the latter by a silicon oxide layer 10. Area Z1 is made, in a way known *per se*, through localized implantation.

20 Figure 6C represents the realization of electric contacts C1 and C2 of the thermometric diode of the bolometric detector. The apertures enabling the contacts C1 and C2 to be made, are made by etching the oxide layer 10. Contacts C1 and C2 are made by metal
25 deposition and etching.

Figure 6D represents the realization of the metal components (2a, 2b, 2c, 2d) which form the antenna of the detector. Preferably, the metal of the antennas has low electric resistivity. The resistance between the
30 extreme points of a same antenna metal component may thus be, for example, of a few ohms. Each metal component for example, comprises three successive metal layers: a first layer, for example of chromium or

titanium, with which good adherence to the oxide may be provided, a second layer, for example of nickel or of palladium, enables a diffusion barrier to be made for the third layer which for example may be in gold.

5 Figure 6E represents the operation for defining the area which localizes the thermometric diode of the detector. For this purpose, dry etching on the front face is successively carried out on the oxide layer 10 and the silicon layer 1.

10 The step represented in Figure 6F consists of depositing a passivation layer 11 and of etching this layer in order to leave free access to the areas for recovering electric contact on the thermometric diode and on the antenna metal components.

15 The step represented in Figure 6G consists of depositing an etching conductor 12 of the conducting structure which for example, may be a metal nitride such as titanium nitride or tungsten nitride.

20 The step represented in Figure 6H consists of removing, in a way known *per se*, the oxide under the thermometric diode and under the area which localizes the thermometric diode in order to form the cavity 7.

25 Figure 7 represents an enhancement of the method for manufacturing a bolometric detector according to Figures 6A-6H.

30 According to this enhancement, the silicon substrate 8 is etched on its rear face under the antenna metal components. This etching enables the dimensions of the resonant cavity to be changed, which is formed by the silicon substrate 8. This change advantageously induces a widening of the absorption spectral band of the detector.

As mentioned earlier, the invention is more

particularly applied to the detection of electromagnetic waves with millimetric wavelengths. The frequencies of the electromagnetic waves detected are, for example, frequencies within the transparent bands
5 of the atmosphere, i.e. frequencies centered around 94 GHz, 140 GHz or even 220 GHz.

Atmospheric transmission in the aforementioned frequency bands is of a higher quality than atmospheric transmission in an infrared band. Advantageously,
10 according to the invention, the result is the possibility of detecting objects under "all weather" conditions (rain, fog, smoke, etc...).

Amended claims to file when entering the National Phase

CLAIMS

1. A bolometric detector comprising at least a receiving antenna (2a, 2b, 2c, 2d) for collecting electromagnetic waves, the receiving antenna having a load resistance, a resistive load for converting the
5 power from the electromagnetic waves into heating power, a thermometric component (4) for measuring the rise in temperature, relatively to a reference temperature, associated with the heating power, characterized in that the resistive load is formed by
10 the load resistance of the antenna.

2. The bolometric detector according to claim 1, characterized in that the thermometric component is a diode (4).

15

3. The bolometric detector according to claim 2, characterized in that the receiving antenna consists of four metal separate components (2a, 2b, 2c, 2d) arranged in the shape of a cross around a central
20 portion (7) so that the first two metal components are aligned along a first axis (AA') and the two other ones are aligned according to an axis perpendicular to the first axis (AA'), wherein the metal components (2a, 2b, 2c, 2d) are arranged on a silicon layer (1), the
25 silicon layer has, at the central portion (7), a recess so that diode (4) is hung above a silicon substrate (8), in that it comprises means for hanging the diode (4) comprising at least a set of two metal arms (3a, 3b), wherein a first metal arm (3a) is connected to a
30 first metal component (2a) and the second metal arm (3c) is connected to the metal component (2c) which is

Amended claims to file when entering the National Phase
aligned with the first metal component (2a).

4. The bolometric detector according to claim 3,
characterized in that the receiving antenna, the diode
5 (4) which comprises the thermometric component and the
means for hanging the diode (4), define, as seen from
above, an occupied space with a square shape, wherein
the side of the square has a length substantially equal
to the wavelength of the detected wave.

10

5. The bolometric detector according to claim 3,
characterized in that the receiving antenna, the diode
(4) which comprises the thermometric component and the
means for hanging the diode (4), define, as seen from
15 above, an occupied space with a square shape, wherein
the side of the square has a length substantially equal
to the half of the wavelength of the detected wave.

6. An imaging device comprising at least a
20 bolometric detector, characterized in that the
bolometric detector is a detector according to any of
claims 1 to 5.

7. The imaging device according to claim 6,
25 characterized in that it comprises at least a set of
four bolometric detectors arranged side by side and the
diodes (4) of which are mounted in parallel.

8. The imaging device according to claim 6,
30 characterized in that it comprises at least a set of
four bolometric detectors arranged side by side, two
first bolometric detectors for collecting waves of the
TE type and two other ones for collecting waves of the

Amended claims to file when entering the National Phase

TM type, wherein diodes (4) of the first two bolometric detectors are associated according to a first parallel circuit and the diodes of the two other bolometric detectors are associated according to a second parallel
5 circuit.

9. The imaging device according to claim 8, characterized in that each bolometric detector comprises a second diode (11) placed in the vicinity of
10 diode (4) which forms the thermometric component, wherein the second diode (11) enables all or part of the parasitic signals received by the bolometric detector to be removed through differential readout of the signals which it generates and of the signals
15 derived from diode (4).

10. A method for manufacturing a bolometric detector comprising a receiving antenna and a thermometric component, characterized in that it
20 consists in the following steps:

- a step for producing a structure formed by the stacking of a silicon substrate (8), an oxide layer (9) and a silicon layer (1) grown by epitaxy,
- a step for producing a doped area (Z1) in the
25 silicon layer (1) in order to form the thermometric component as a diode (4) and to cover the silicon layer (1) with a silicon oxide layer (10),
- a step for producing the electric contacts (C1, C2) of the diode (4),
- 30 - a step for producing, by depositing a metal on the silicon oxide layer (10), the metal components (2a, 2b, 2c, 2d) forming the receiving antenna,
- a step consisting of dry etching the oxide (10)

Amended claims to file when entering the National Phase

and the silicon (1) layers in order to define a recessed area which localizes the diode (4),

- a step consisting of depositing a passivation layer (11) and of etching this layer (11) in order to
5 leave free access to the electric contacts (C1, C2) of diode (4) and areas for recovering electric contact with the antenna metal components,

- a step consisting of depositing a conducting layer (12) on the electric contacts (C1, C2) of diode
10 (4), on the areas for recovering electric contact with the antenna metal components and on the recessed area which localizes the diode (4),

- a step for removing the oxide located under the diode (4) and under the recessed area which localizes
15 the diode (4) in order to create a cavity (7).

11. Method for manufacturing a bolometric detector according to claim 10, characterized in that it comprises an extra step consisting of etching the
20 silicon substrate (8) under the antenna metal components.

English translation of the amended sheets of
International Preliminary Examination Report

CLAIMS

1. A bolometric detector comprising at least a receiving antenna (2a, 2b, 2c, 2d) for collecting electromagnetic waves, the receiving antenna having a load resistance, a resistive load for converting the power from the electromagnetic waves into heating power, a thermometric component (4) for measuring the rise in temperature, relatively to a reference temperature, associated with the heating power, characterized in that the resistive load is formed by the load resistance of the antenna and in that the thermometric component is electrically insulated from the load resistance of the antenna.

2. The bolometric detector according to claim 1, characterized in that the thermometric component is a diode (4).

3. The bolometric detector according to claim 2, characterized in that the receiving antenna consists of four metal separate components (2a, 2b, 2c, 2d) arranged in the shape of a cross around a central portion (7) so that the first two metal components are aligned along a first axis (AA') and the two other ones are aligned according to an axis perpendicular to the first axis (AA'), wherein the metal components (2a, 2b, 2c, 2d) are arranged on a silicon layer (1), the silicon layer has, at the central portion (7), a recess so that diode (4) is hung above a silicon substrate (8), in that it comprises means for hanging the diode (4) comprising at least a set of two metal arms (3a,

English translation of the amended sheets of
International Preliminary Examination Report

3b), wherein a first metal arm (3a) is connected to a first metal component (2a) and the second metal arm (3c) is connected to the metal component (2c) which is aligned with the first metal component (2a).

5

4. The bolometric detector according to claim 3, characterized in that the receiving antenna, the diode (4) which comprises the thermometric component and the means for hanging the diode (4), define, as seen from above, an occupied space with a square shape, wherein the side of the square has a length substantially equal to the wavelength of the detected wave.

5. The bolometric detector according to claim 3, characterized in that the receiving antenna, the diode (4) which comprises the thermometric component and the means for hanging the diode (4), define, as seen from above, an occupied space with a square shape, wherein the side of the square has a length substantially equal to the half of the wavelength of the detected wave.

6. An imaging device comprising at least a bolometric detector, characterized in that the bolometric detector is a detector according to any one of claims 1 to 5.

7. The imaging device according to claim 6, characterized in that it comprises at least a set of four bolometric detectors arranged side by side and the diodes (4) of which are mounted in parallel.

8. The imaging device according to claim 6,

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characterized in that it comprises at least a set of four bolometric detectors arranged side by side, two first bolometric detectors for collecting waves of the TE type and two other ones for collecting waves of the TM type, wherein diodes (4) of the first two bolometric detectors are associated according to a first parallel circuit and the diodes of the two other bolometric detectors are associated according to a second parallel circuit.

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9. The imaging device according to claim 8, characterized in that each bolometric detector comprises a second diode (11) placed in the vicinity of diode (4) which forms the thermometric component, wherein the second diode (11) enables all or part of the parasitic signals received by the bolometric detector to be removed through differential readout of the signals which it generates and of the signals derived from diode (4).

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10. A method for manufacturing a bolometric detector comprising a receiving antenna and a thermometric component, characterized in that it consists in the following steps:

25 - a step for producing a structure formed by the stacking of a silicon substrate (8), an oxide layer (9) and a silicon layer (1) grown by epitaxy,

- a step for producing a doped area (Z1) in the silicon layer (1) in order to form the thermometric component as a diode (4) and to cover the silicon layer (1) with a silicon oxide layer (10),

30 - a step for producing the electric contacts (C1,

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International Preliminary Examination Report

C2) of the diode (4),

- a step for producing, by depositing a metal on the silicon oxide layer (10), the metal components (2a, 2b, 2c, 2d) forming the receiving antenna,

5 - a step consisting of dry etching the oxide (10) and the silicon (1) layers in order to define a recessed area which localizes the diode (4),

10 - a step consisting of depositing a passivation layer (11) and of etching this layer (11) in order to leave free access to the electric contacts (C1, C2) of diode (4) and areas for recovering electric contact with the antenna metal components,

15 - a step consisting of depositing a conducting layer (12) on the electric contacts (C1, C2) of diode (4), on the areas for recovering electric contact with the antenna metal components and on the recessed area which localizes the diode (4),

20 - a step for removing the oxide located under the diode (4) and under the recessed area which localizes the diode (4) in order to create a cavity (7).

25 11. Method for manufacturing a bolometric detector according to claim 10, characterized in that it comprises an extra step consisting of etching the silicon substrate (8) under the antenna metal components.